

<b>Issue Classification</b>		Application/Control No.	Applicant(s)/Patent under Reexamination			
		10645294	TANAKA, TOKIO			
Examiner			Art Unit			
Layno, Benjamin H			3711			

<b>ORIGINAL</b>		<b>INTERNATIONAL CLASSIFICATION</b>					
CLASS		SUBCLASS	CLAIMED			NON-CLAIMED	
273		308	A	6	3	F	1 / 00
<b>CROSS REFERENCE(S)</b>							
<b>CLASS</b>		<b>SUBCLASS (ONE SUBCLASS PER BLOCK)</b>					
273		302	292				
D21		384	383	376			
NONE (Assistant Examiner)		(Date)	08/04/06 Benjamin Layno (Primary Examiner)				Total Claims Allowed: 5
<i>Benjamin Layno</i> (Legal Instruments Examiner)		(Date)	O.G. Print Claim(s) 1				O.G. Print Figure 2A, 3A, 4B